## Notice of References Cited Application/Control No. 10/649,640 Examiner Ly T. TRAN Applicant(s)/Patent Under Reexamination NAKAGAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,257,696	07-2001	Nakamura, Hirotake	347/30
	В	US-5,132,710	07-1992	Ejiri et al.	347/3
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Ø						
	R						
	S						
	Т						

## NON-PATENT DOCUMENTS

NON-FATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.